

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re application of: Doerr et al.

Application No. 10/801,481

Filed: March 15, 2004

FILED VIA EFS ON 27 March 2009

Confirmation No. 1207

For: LINEAR OPTICAL SAMPLING
METHODS AND APPARATUS

Examiner: Wai Lun Leung

Art Unit: 2613

Attorney Reference No. 1505-67922-01

COMMISSIONER FOR PATENTS

Comments on Statement of Reasons for Allowance

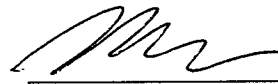
Page 2 of the Notice of Allowability provides a statement of reasons for allowance in which the Examiner lists combinations of elements and features that he asserts are found or not found in the prior art of record. One or more of the allowed claims may not recite all elements or features of the combinations given in the statement of reasons for allowance. Any element or feature that is not specifically recited in a claim does not limit the claim's scope. Applicants do not admit that any element or feature listed in the statement of reasons for allowance limits a claim unless the element or feature is specifically recited in the claim.

Respectfully submitted,

KLARQUIST SPARKMAN, LLP

One World Trade Center, Suite 1600
121 S.W. Salmon Street
Portland, Oregon 97204
Telephone: (503) 595-5300
Facsimile: (503) 595-5301

By



Michael D. Jones

Registration No. 41,879